

<b>Notice of References Cited</b>	Application/Control No. 10/552,497		Applicant(s)/Patent Under Reexamination HANSEN ET AL.	
	Examiner Binh X. Tran		Art Unit 1792	Page 1 of 1

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*	B	US-5,935,643	08-1999	Song et al.	427/115
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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